



The Sub: Status Report

Submersible cryostat for cold-electronics testing and pulse-shape investigations

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Overview



- 1. Goals of The Sub**
- 2. System description: cryostat and electronics**
- 3. Performance and first results**
- 4. Outlook**

The Sub: Goals

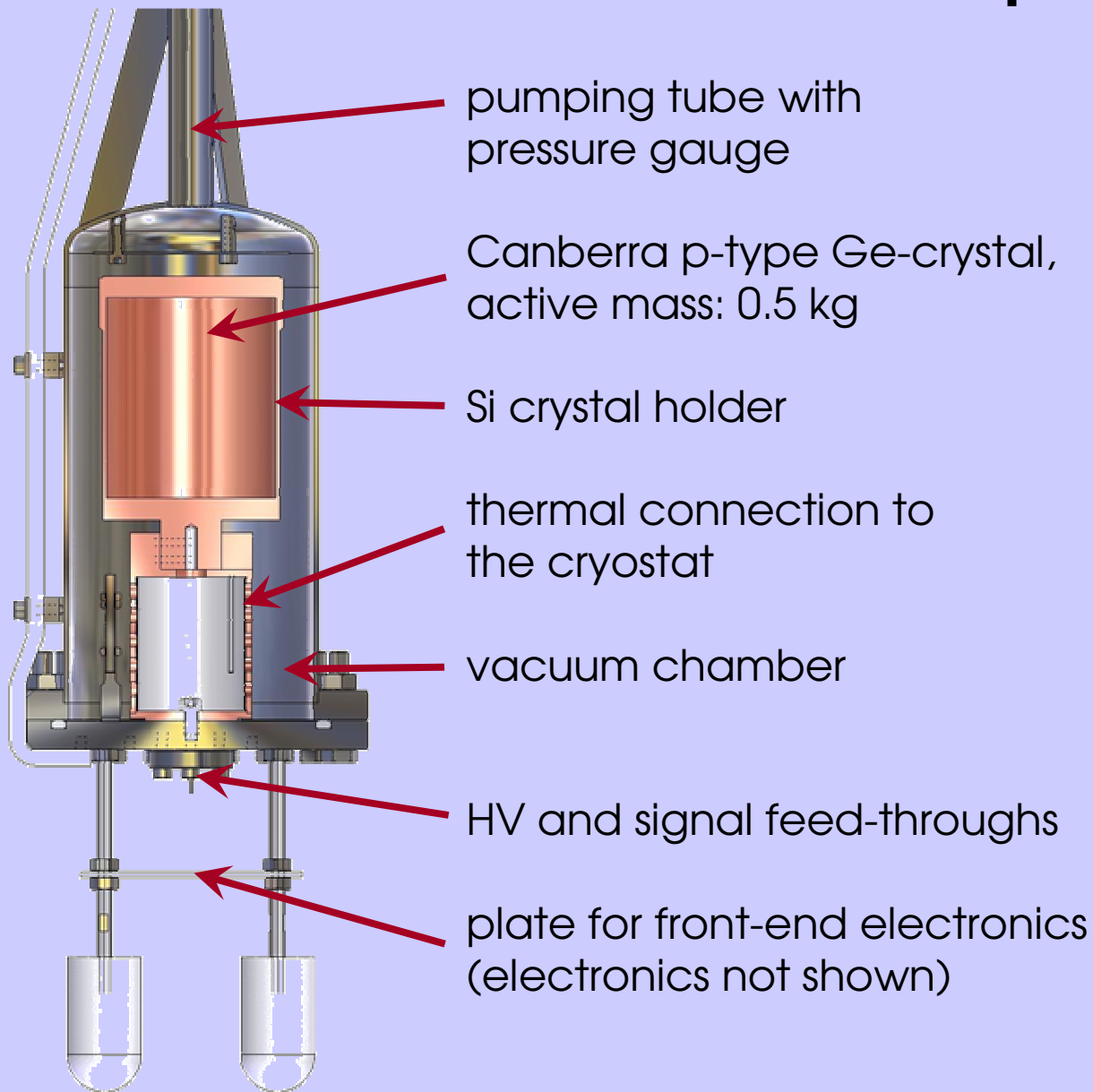
1. Test front-end electronics in liquid argon with p-type Ge-crystal,

with Ge-detector operated in vacuum cryostat and preamplifiers working in cryogenic liquid.

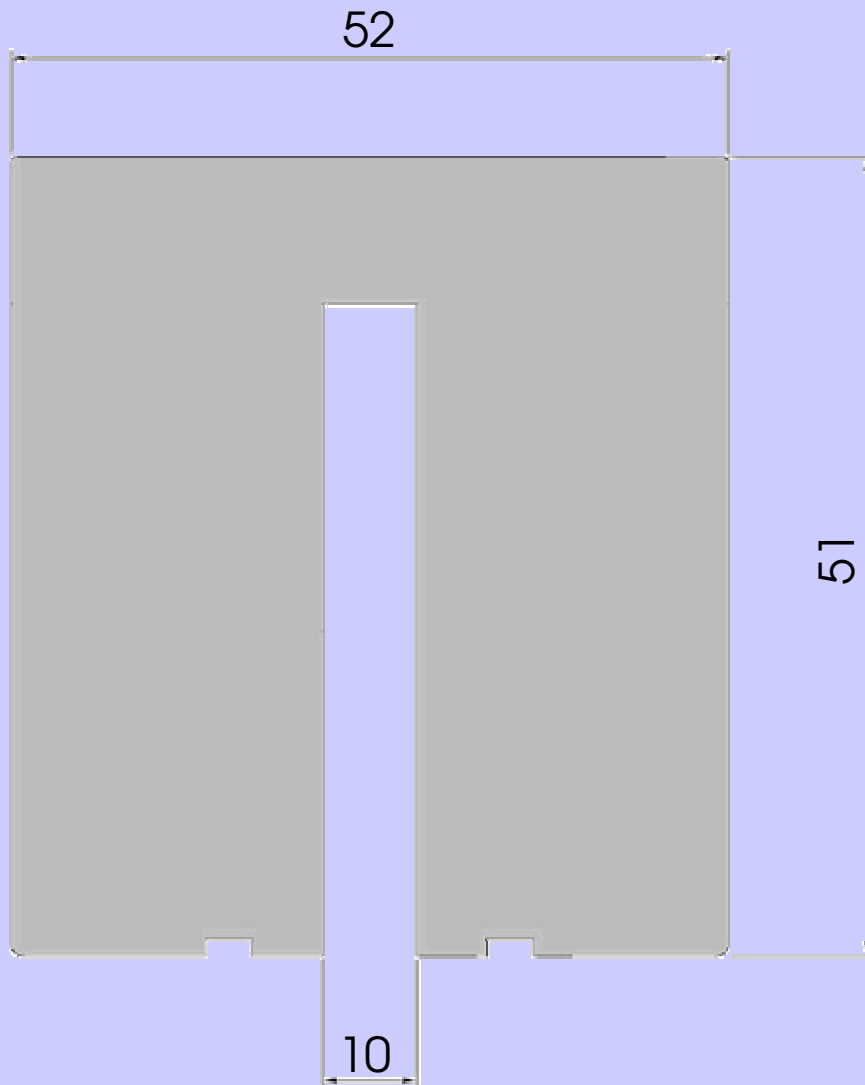
2. Study pulse-shape discrimination using a coaxial unsegmented p-type detector with Phase I FE electronics.

Single-site vs. multi-site events discrimination with detector setup analogous to GERDA Phase I, including the 5m long transmission lines from preamplifiers.

The Sub: Description



The crystal



Crystal mounted on the
cryostat flange.

The Sub setup in Low-level laboratory



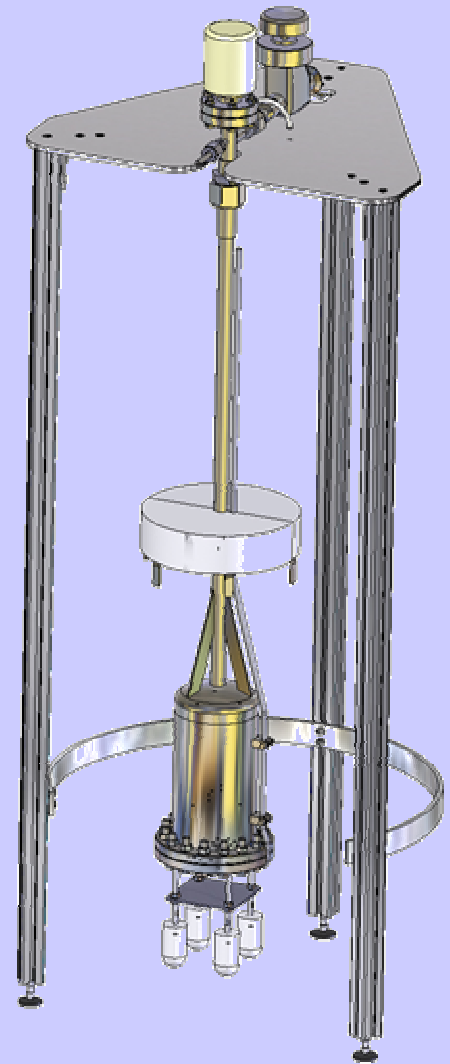
pressure gauge

valve

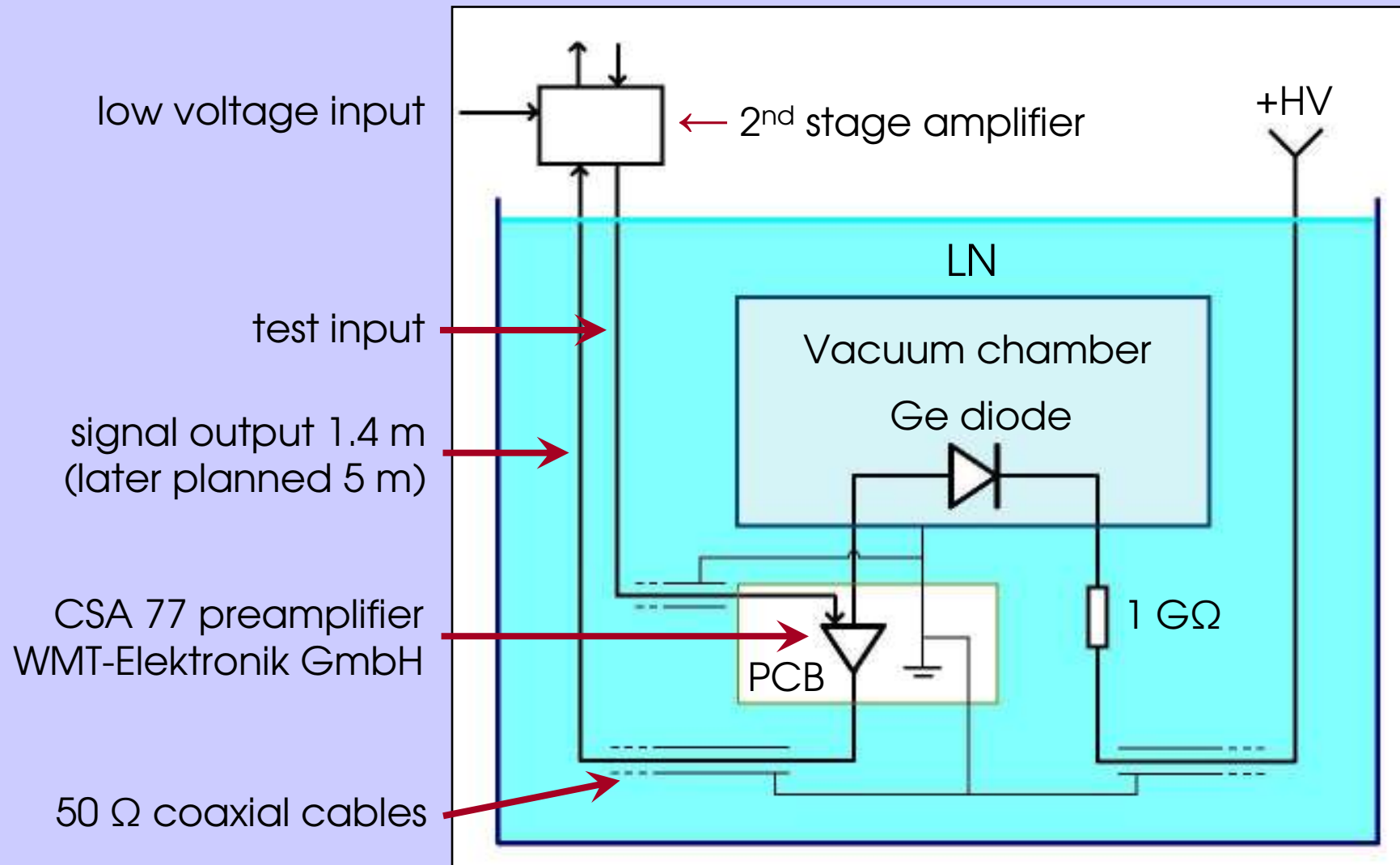
pumping tube

dewar: ~25l

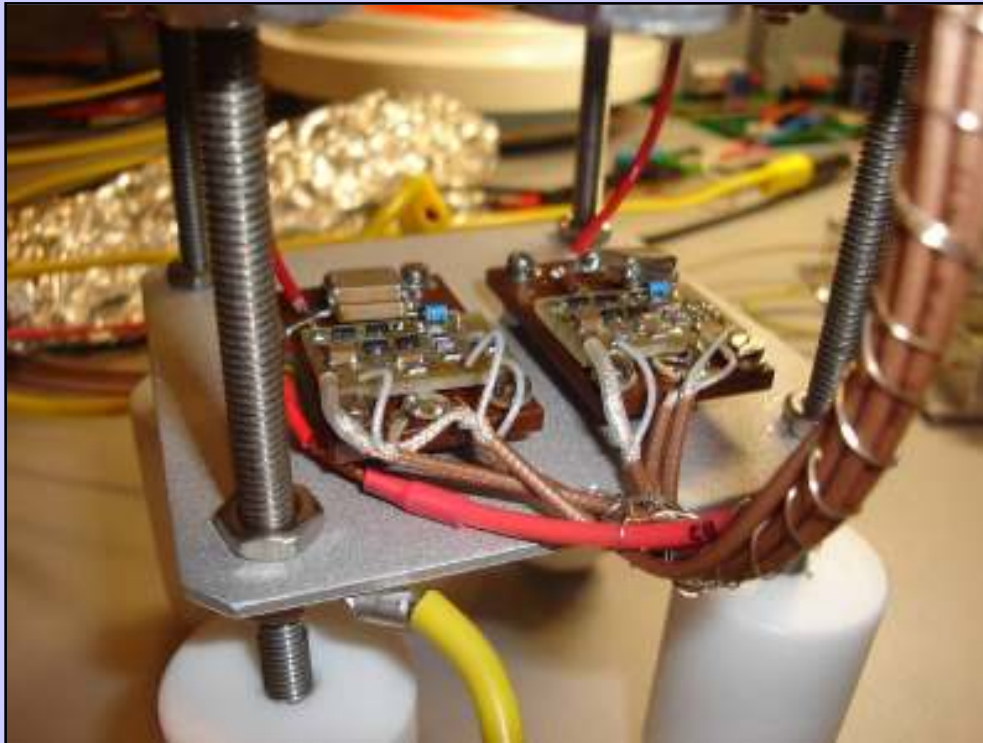
turbopump



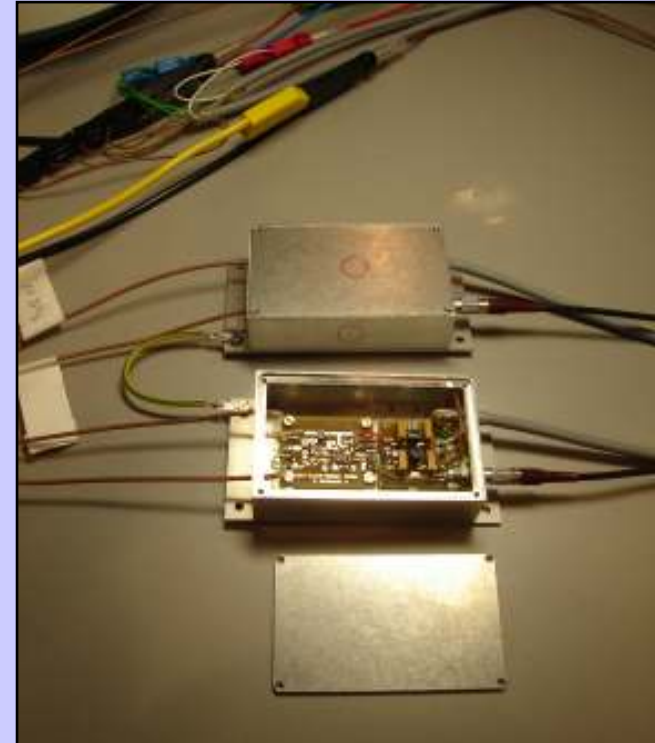
Front-end electronics layout



CSA-77 preamplifiers



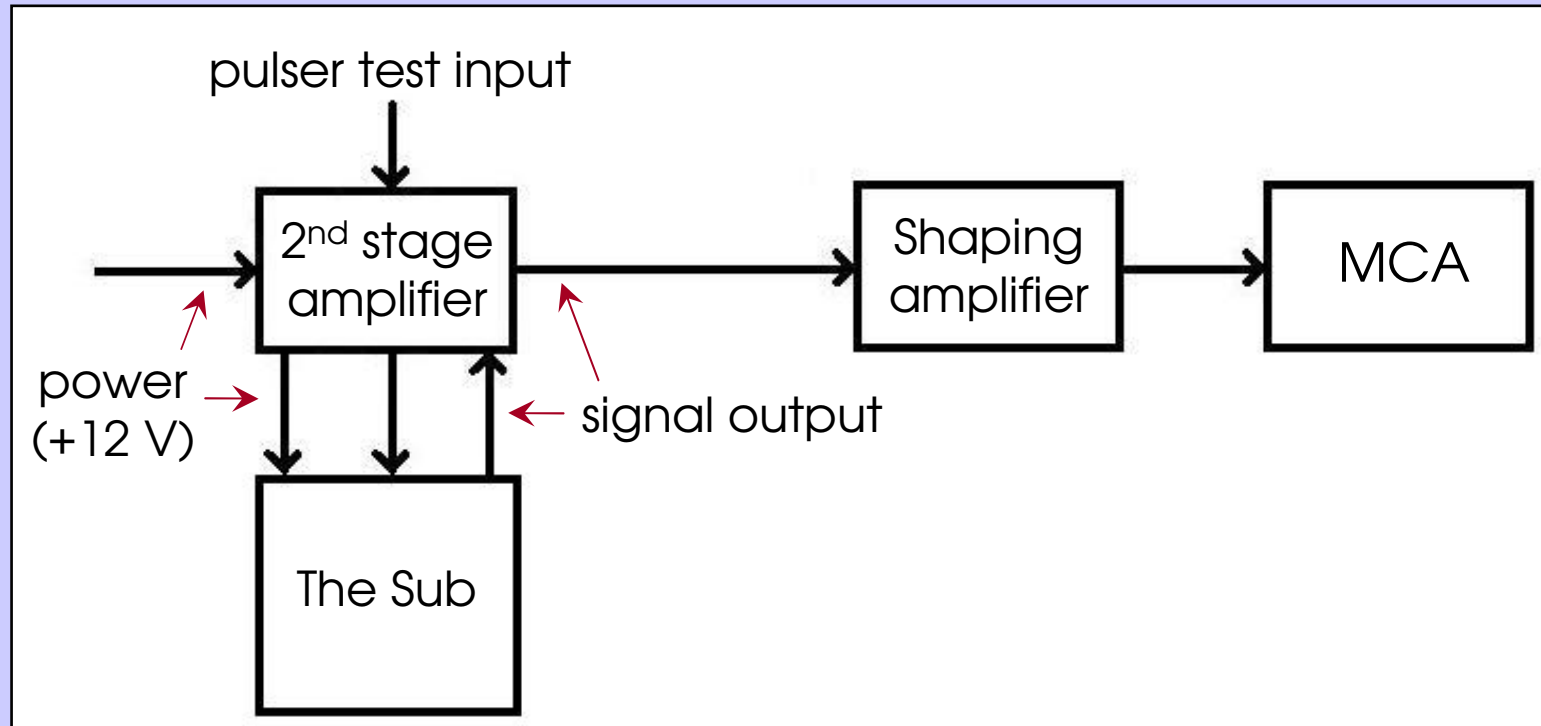
The CSA-77 preamplifiers installed below the cryostat.



The main amplifier boxes.

- two preamplifiers: HV and signal side readout planned
- currently only standard single channel readout is used

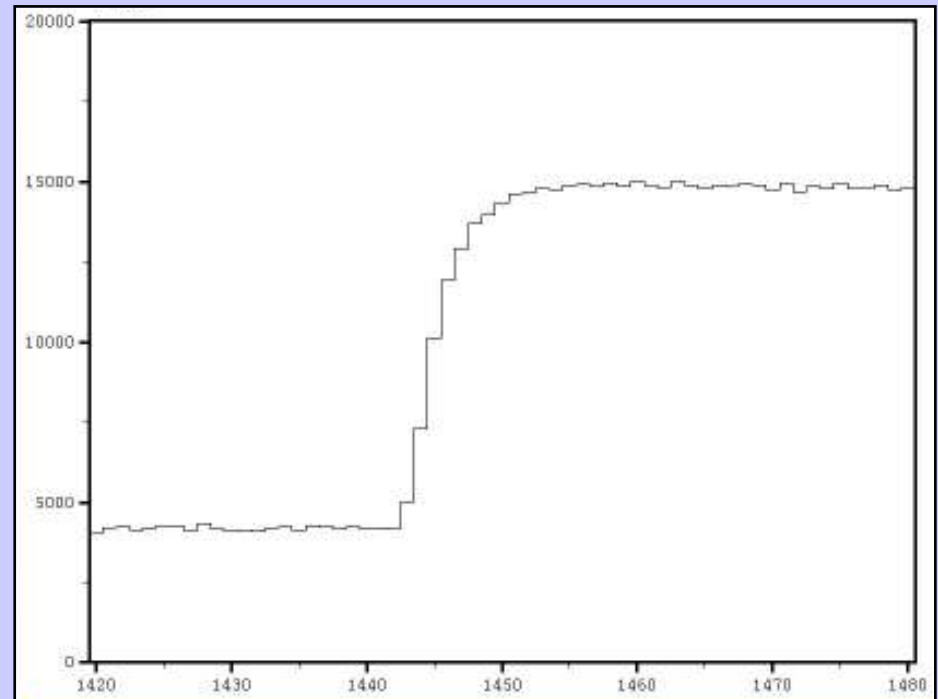
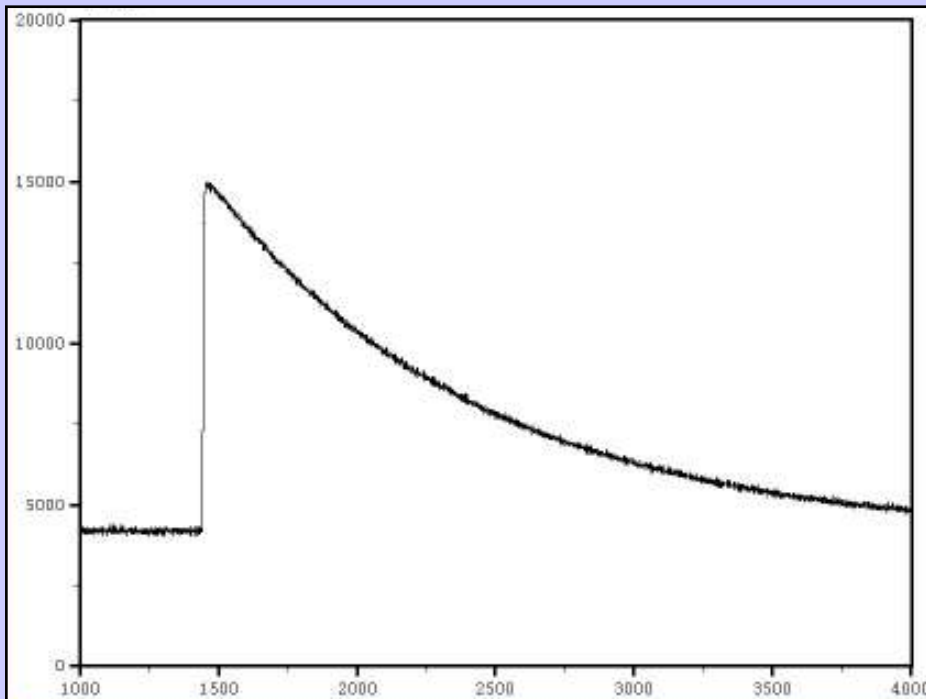
Data acquisition layout



- pulse-shape recording:
Struck SIS 3301 FADC with 14-bit resolution
sampling rate: 100 MHz
- digitized shaping for pulse-height spectra recording

First results with 33pF capacitor

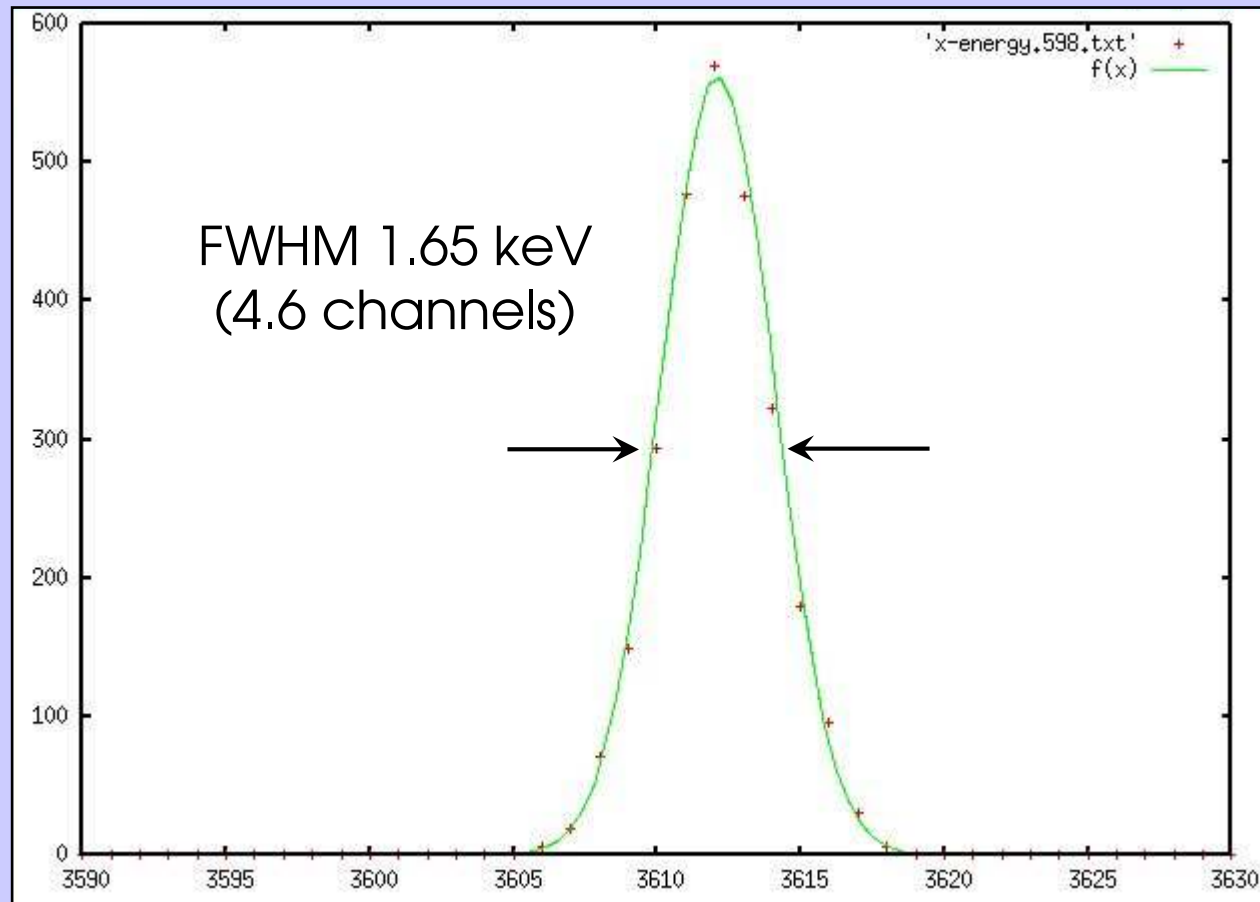
FADC pulse shape: pulser



- measurement performed using test pulse with 50ns rise time
- detector substituted by 33pF capacitor mounted on the PCB

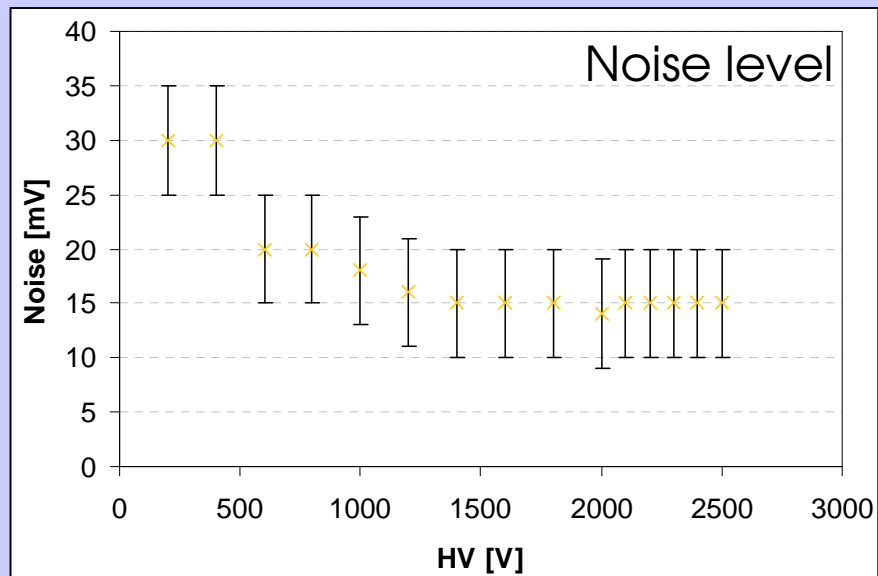
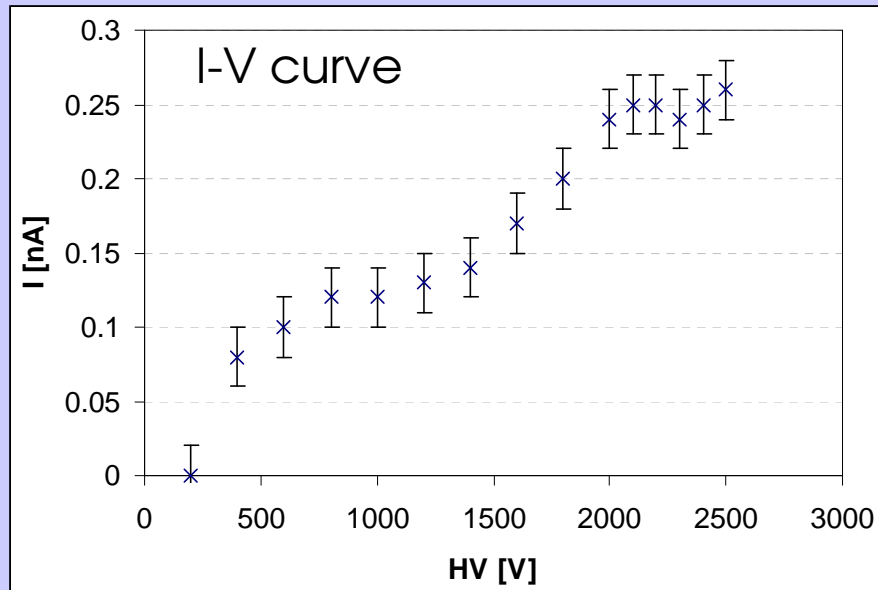
First results with 33pF capacitor

Pulser FADC spectrum:



- recorded with 1.6 μ s shaping time

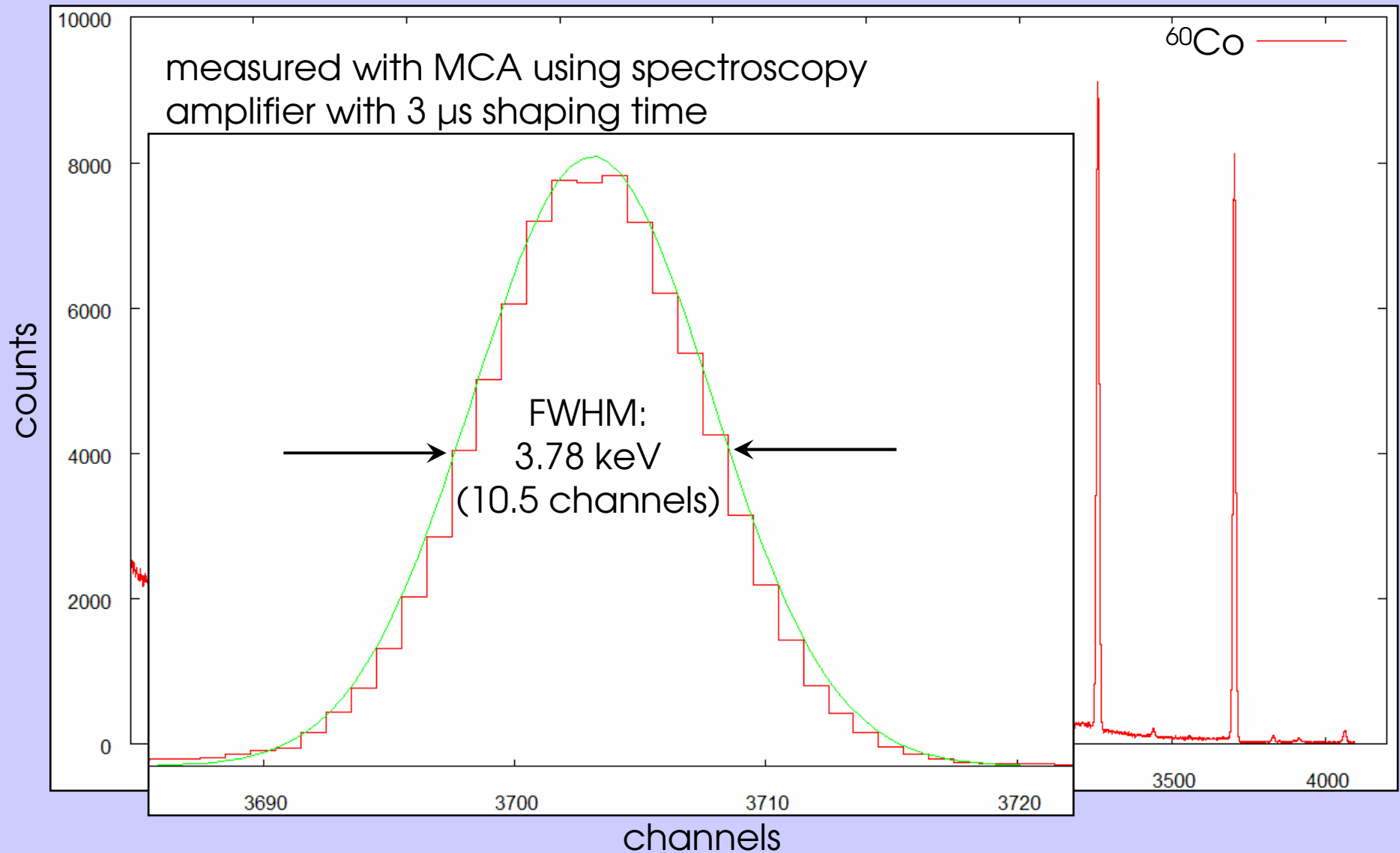
Performance with Ge-crystal



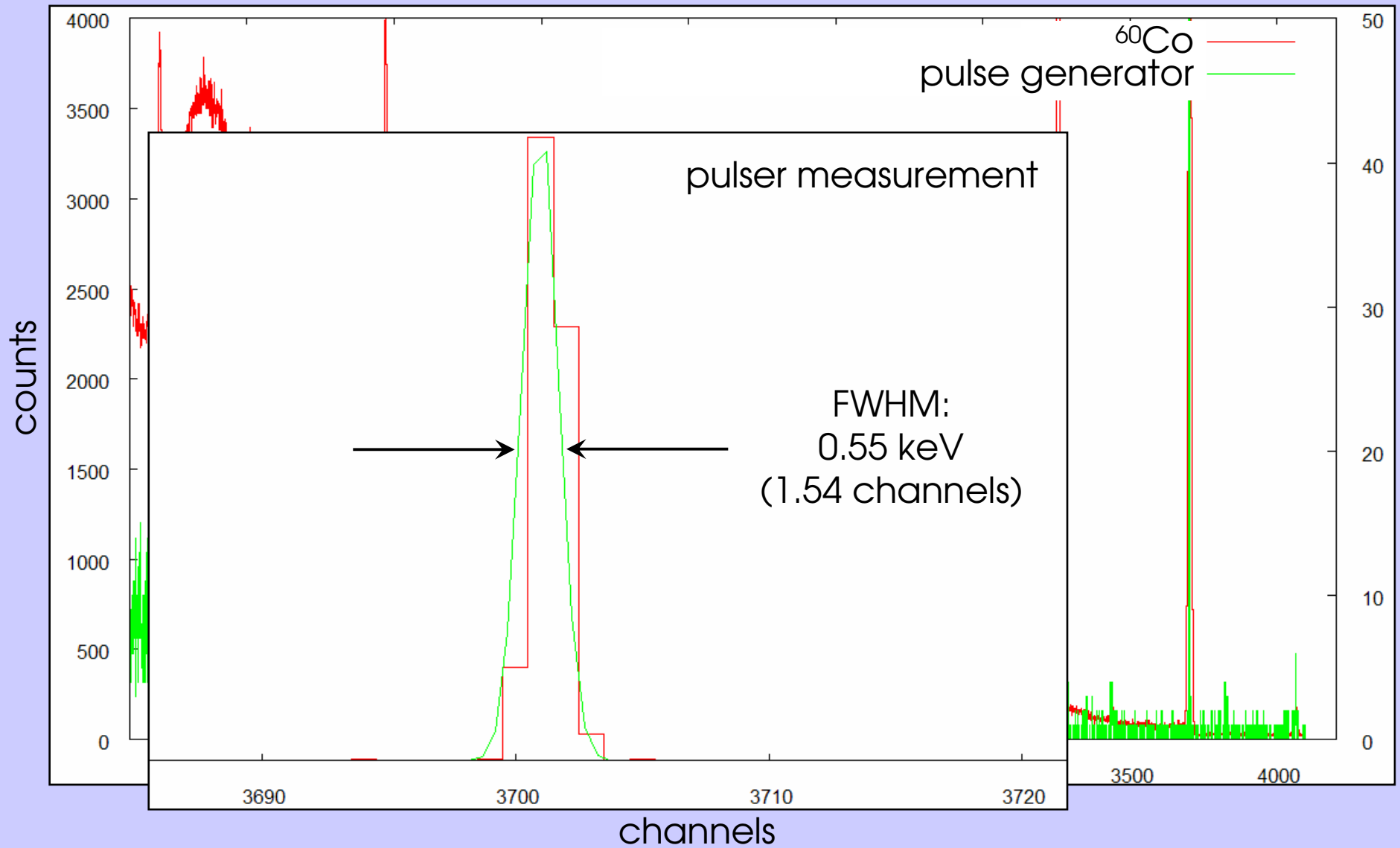
First time HV applied on the detector:

- leakage current measured with pA-meter
- baseline noise of signal output after shaping amplifier measured with oscilloscope
- full depletion reached at ~ 1500 V
- detector operating voltage: 2500 V
- measurements were done with another preamplifier than the previous pulser test

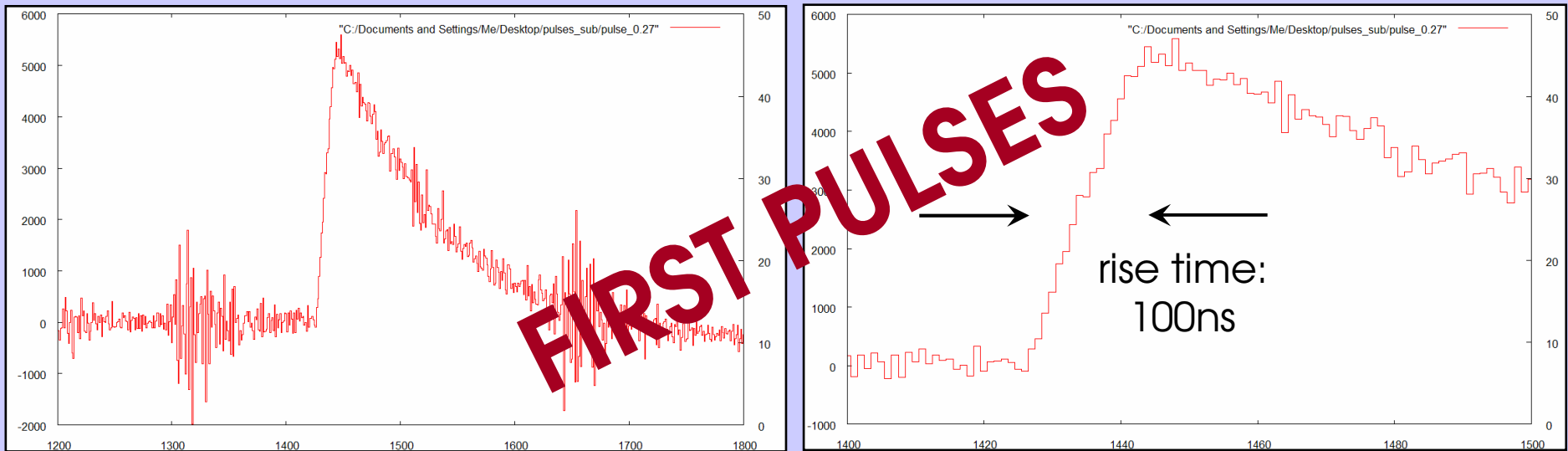
First results with Ge-crystal



First results with Ge-crystal



First pulse-shapes



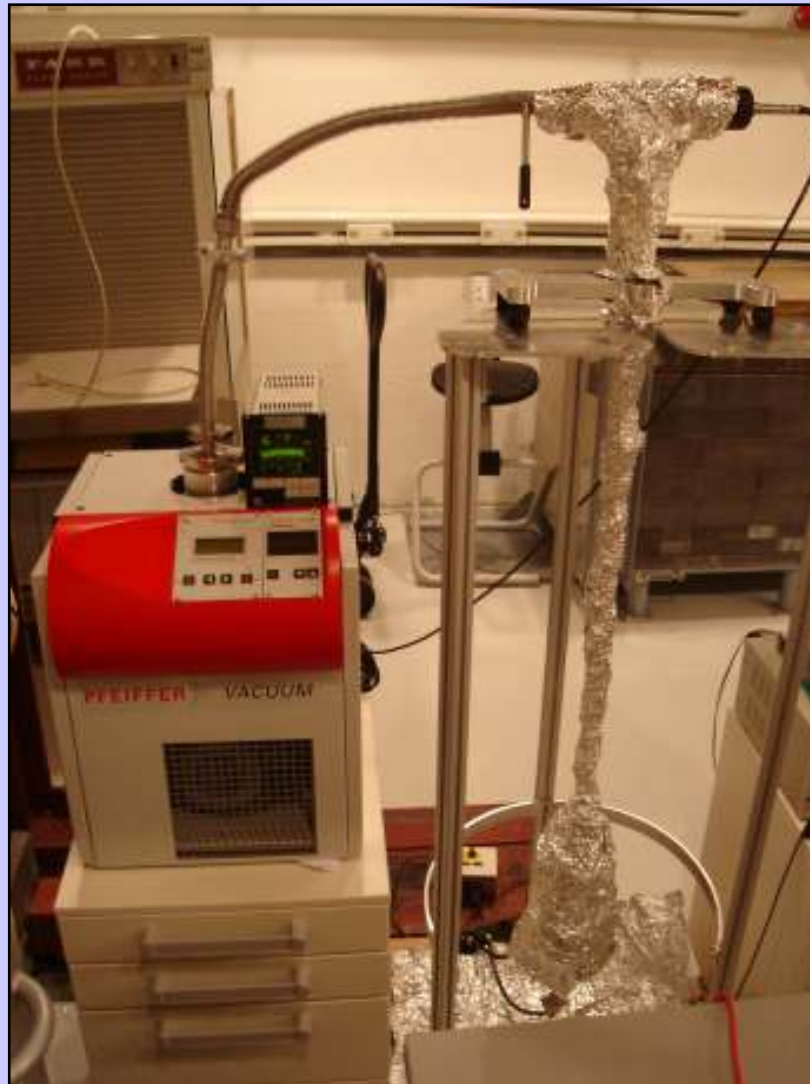
Outlook



1. understand source of present high-frequency noise and find ways to eliminate it
2. record pulse-shapes of single-site and multi-site events (DEP, coincidence measurements, FE-peak) and test discrimination methods
3. tests of different Phase I FE electronics solutions - in coordination and collaboration within TG-3

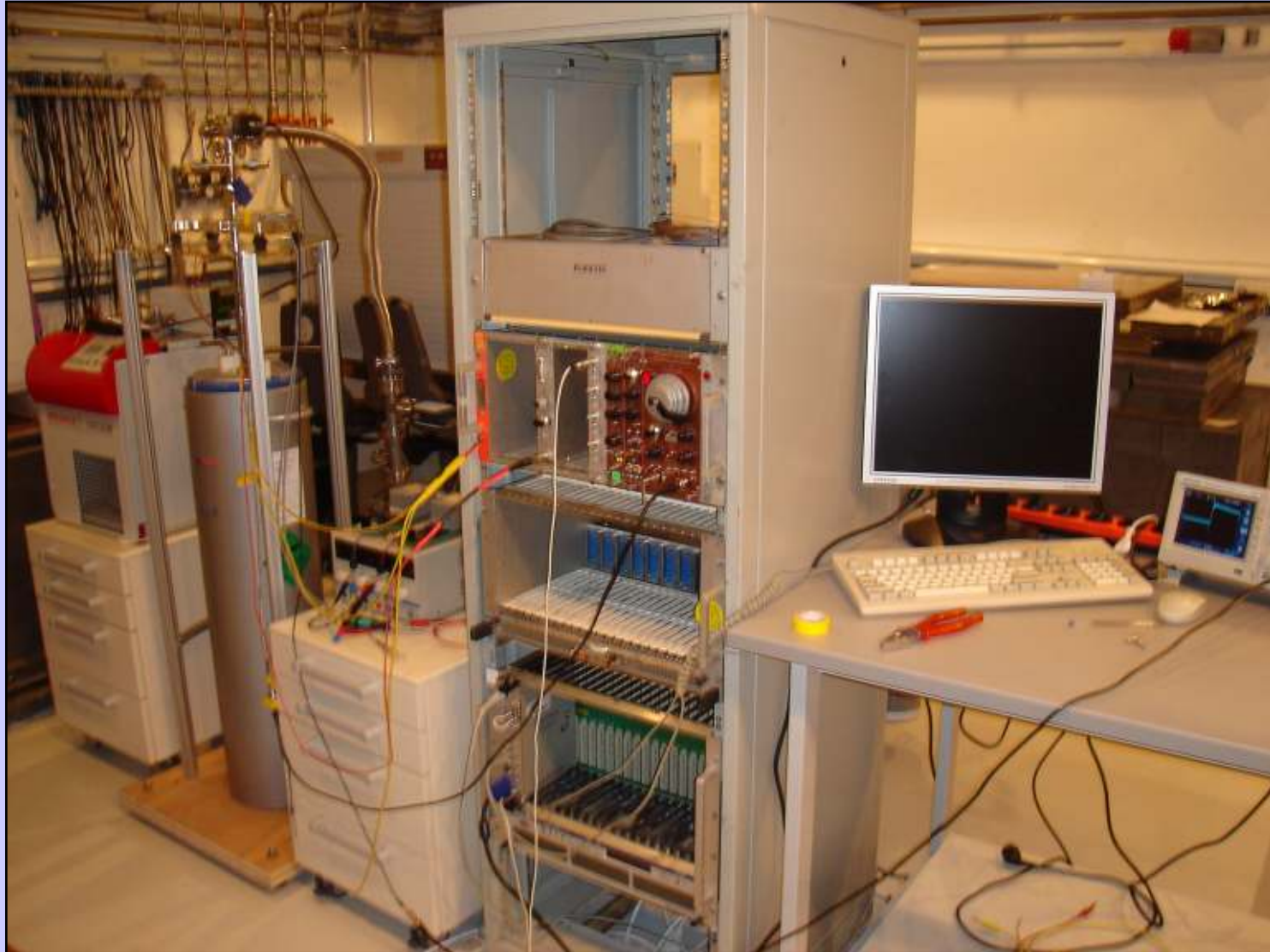
Appendix

Appendix



Heating and pumping of
the cryostat.

Appendix



Whole setup with the electronics rack in low-level lab.

Appendix



Measurements with ^{60}Co source.

Appendix

